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#### ADS7887, ADS7888

SLAS468A -JUNE 2005-REVISED AUGUST 2016

# ADS788x 10-Bit, 8-Bit, 1.25-MSPS, Micro-Power, Miniature SAR Analog-to-Digital Converters

Technical

Documents

#### Features 1

- 1.25-MHz Sample Rate Serial Device
- 10-Bit Resolution (ADS7887)
- 8-Bit Resolution (ADS7888)
- Zero Latency
- 25-MHz Serial Interface
- Supply Range: 2.35 V to 5.25 V
- Typical Power Dissipation at 1.25 MSPS:
  - 3.8 mW at 3-V V<sub>DD</sub>
  - 8 mw at 5-V V<sub>DD</sub>
- ±0.35 LSB INL, DNL (ADS7887)
- ±0.15 LSB INL, ±0.1 LSB DNL (ADS7888)
- 61 dB SINAD, -84 dB THD (ADS7887)
- 49.5 dB SINAD, -67.5 dB THD (ADS7888)
- Unipolar Input Range: 0 V to V<sub>DD</sub>
- Power-Down Current: 1 µA
- Wide Input Bandwidth: 15 MHz at 3 dB
- 6-Pin SOT23 and SC70 Packages

#### Applications 2

- Base Band Converters in Radio Communication
- Motor Current and Bus Voltage Sensors in Digital Drives
- Optical Networking (DWDM, MEMS-Based Switching)
- **Optical Sensors**
- **Battery-Powered Systems**
- Medical Instrumentations
- High-Speed Data Acquisition Systems
- High-Speed Closed-Loop Systems

# 3 Description

Tools &

Software

The ADS7887 device is a 10-bit, 1.25-MSPS, analogto-digital converter (ADC), and the ADS7888 device is a 8-bit, 1.25-MSPS ADC. These devices include a capacitor-based SAR A/D converter with inherent sample and hold. The serial interface in each device is controlled by the  $\overline{CS}$  and SCLK signals for glueless connections with microprocessors and DSPs. The input signal is sampled with the falling edge of  $\overline{CS}$ , and SCLK is used for conversion and serial data output.

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The devices operate from a wide supply range from 2.35 V to 5.25 V. The low power consumption of the devices make them suitable for battery-powered applications. The devices also include a powersaving, power-down feature for when the devices are operated at lower conversion speeds.

The high level of the digital input to the device is not limited to device V<sub>DD</sub>. This means the digital input can go as high as 5.25 V when device supply is 2.35 V. This feature is useful when digital signals are coming from other circuit with different supply levels. Also this relaxes restriction on power-up sequencing.

The ADS7887 and ADS7888 are available in 6-pin SOT-23 and SC70 packages and are specified for operation from -40°C to 125°C.

#### Device Information<sup>(1)</sup>

| PART NUMBER | PACKAGE    | BODY SIZE (NOM)   |
|-------------|------------|-------------------|
| ADS7887     | SOT-23 (6) | 2.90 mm × 1.60 mm |
| ADS7888     | SC70 (6)   | 2.00 mm × 1.25 mm |

(1) For all available packages, see the orderable addendum at the end of the data sheet.

#### SAR OUTPUT LATCHES AND 3-STATE SDO DRIVERS +IN CDAC COMPARATOR VDD CONVERSION SCLK AND ADS7887/ADS7888 CONTROL CS LOGIC

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# **Functional Block Diagram**

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## **4** Revision History

NOTE: Page numbers for previous revisions may differ from page numbers in the current version.

Changes from Original (June 2005) to Revision A

| • | Added ESD Ratings table, Feature Description section, Device Functional Modes, Application and Implementation |   |
|---|---|---|
|   | section, Power Supply Recommendations section, Layout section, Device and Documentation Support section, and  |   |
|   | Mechanical, Packaging, and Orderable Information section  | 1 |
| • | Changed Thermal Information table   | 6 |

# EXAS **ISTRUMENTS**

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# **5** Companion Products

| PART NUMBER  | NAME  |
|--------------|---|
| SN74LVTH245A | 3.3-V ABT Octal Bus Transceivers With 3-State Outputs         |
| LMV761       | Low Voltage, Precision Comparator with Push-Pull Output       |
| TPS54418     | 2.95V to 6V Input, 4A Synchronous Step-Down SWIFT™ Converter  |
| LMV339       | Quad General Purpose Low-Voltage Comparators                  |
| TPS730       | Low-Noise, High PSRR, RF 200-mA Low-Dropout Linear Regulators |



# 6 Device Comparison

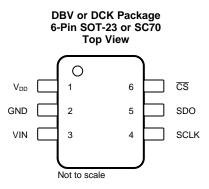
| BIT    | BIT     < 300 KSPS                                    |   |
|--------|---|---|
| 12-Bit | ADS7866 (1.2 V <sub>DD</sub> to 3.6 V <sub>DD</sub> ) | ADS7886 (2.35 V <sub>DD</sub> to 5.25 V <sub>DD</sub> ) |
| 10-Bit | ADS7867 (1.2 V <sub>DD</sub> to 3.6 V <sub>DD</sub> ) | ADS7887 (2.35 V <sub>DD</sub> to 5.25 V <sub>DD</sub> ) |
| 8-Bit  | ADS7868 (1.2 V <sub>DD</sub> to 3.6 V <sub>DD</sub> ) | ADS7888 (2.35 V <sub>DD</sub> to 5.25 V <sub>DD</sub> ) |

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#### ADS7887, ADS7888 SLAS468A – JUNE 2005 – REVISED AUGUST 2016

# 7 Pin Configuration and Functions



#### **Pin Functions**

| PIN       NO.     NAME       1     V <sub>DD</sub> 2     GND       3     VIN       4     SCLK       5     SDO | I/O             | DESCRIPTION |   |  |  |
|---|-----------------|-------------|---|--|--|
| NO. NAME  |                 | 1/0         | DESCRIPTION   |  |  |
| 1   | V <sub>DD</sub> | _           | Power supply input also acts like a reference voltage to ADC.                             |  |  |
| 2   | GND             | -           | d for power supply, all analog and digital signals are referred with respect to this pin. |  |  |
| 3   | VIN             | Ι           | og signal input   |  |  |
| 4   | SCLK            | Ι           | Serial clock  |  |  |
| 5   | SDO             | 0           | Serial data out   |  |  |
| 6   | CS              | Ι           | Chip select signal, active low  |  |  |

# 8 Specifications

### 8.1 Absolute Maximum Ratings

over operating free-air temperature range (unless otherwise noted)<sup>(1)</sup>

|   |                    | м   | IN    | MAX                                   | UNIT |  |
|---|--------------------|-----|-------|---------------------------------------|------|--|
| +IN to AGND                               |                    | -0  | ).3   | V <sub>DD</sub> + 0.3                 | V    |  |
| +V <sub>DD</sub> to AGND                  |                    | -0  | ).3   | 7                                     | V    |  |
| Digital input voltage to GND              |                    | -0  | ).3   | 7                                     | V    |  |
| Digital output to GND                     |                    | -0  | ).3   | V <sub>DD</sub> + 0.3                 | V    |  |
| Power dissipation, both packages          |                    | (TJ | (MAX) | – T <sub>A</sub> ) / R <sub>θJA</sub> |      |  |
| Lood tomporature, coldoring               | Vapor phase (60 s) |     |       | 215                                   | *    |  |
| Lead temperature, soldering               | Infrared (15 s)    |     | 220   |                                       | °C   |  |
| Junction temperature, T <sub>J(MAX)</sub> |                    |     |       | 150                                   | °C   |  |
| Storage temperature, T <sub>stg</sub>     |                    | -6  | 65    | 150                                   | °C   |  |

(1) Stresses beyond those listed under Absolute Maximum Ratings may cause permanent damage to the device. These are stress ratings only, which do not imply functional operation of the device at these or any other conditions beyond those indicated under Recommended Operating Conditions. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

### 8.2 ESD Ratings

|  | V <sub>(ESD)</sub> Electrostatic discharge Human-body model (HBM), per ANSI/ESDA/JEDEC JS-001 <sup>(1)</sup> ±2 | VALUE   | UNIT  |   |
|--|---|---|-------|---|
| V  | Electrostatia discharge   | Human-body model (HBM), per ANSI/ESDA/JEDEC JS-001 <sup>(1)</sup> | ±2000 | V |
| V <sub>(ESD)</sub> Electrostatic discharge | Charged-device model (CDM), per JEDEC specification JESD22-C101 <sup>(2)</sup>                                  | ±500  | v     |   |

(1) JEDEC document JEP155 states that 500-V HBM allows safe manufacturing with a standard ESD control process.

(2) JEDEC document JEP157 states that 250-V CDM allows safe manufacturing with a standard ESD control process.

### 8.3 Recommended Operating Conditions

over operating free-air temperature range (unless otherwise noted)

|                |                       | MIN | MAX | UNIT |
|----------------|-----------------------|-----|-----|------|
| T <sub>A</sub> | Operating temperature | -40 | 125 | °C   |

#### 8.4 Thermal Information

|                       |  | ADS7887,     | ADS7888    |      |
|-----------------------|--|--------------|------------|------|
|                       | THERMAL METRIC <sup>(1)</sup>                | DBV (SOT-23) | DCK (SC70) | UNIT |
|                       |  | 6 PINS       | 6 PINS     |      |
| $R_{\thetaJA}$        | Junction-to-ambient thermal resistance       | 114.9        | 150.7      | °C/W |
| R <sub>0JC(top)</sub> | Junction-to-case (top) thermal resistance    | 56.6         | 62.3       | °C/W |
| $R_{\thetaJB}$        | Junction-to-board thermal resistance         | 36.5         | 43         | °C/W |
| ΨJT                   | Junction-to-top characterization parameter   | 5.8          | 1.8        | °C/W |
| ΨЈВ                   | Junction-to-board characterization parameter | 36.2         | 42.4       | °C/W |
| R <sub>0JC(bot)</sub> | Junction-to-case (bottom) thermal resistance | —            | —          | °C/W |

(1) For more information about traditional and new thermal metrics, see the Semiconductor and IC Package Thermal Metrics application report.



### 8.5 Electrical Characteristics – ADS7887

 $+V_{DD} = 2.35$  V to 5.25 V, T<sub>A</sub> = -40°C to 125°C, and f<sub>sample</sub> = 1.25 MHz (unless otherwise noted)

|                   | PARAMETER                                    | TEST CONDITIONS                              | MIN                   | TYP   | MAX                   | UNIT              |
|-------------------|--|--|-----------------------|-------|-----------------------|-------------------|
| ANALO             | G INPUT                                      |  |                       |       |                       |                   |
|                   | Full-scale input voltage span <sup>(1)</sup> |  | 0                     |       | V <sub>DD</sub>       | V                 |
|                   | Absolute input voltage range                 | +IN  | -0.2                  |       | V <sub>DD</sub> + 0.2 | V                 |
| C <sub>i</sub>    | Input capacitance <sup>(2)</sup>             |  |                       | 21    |                       | pF                |
| l <sub>likg</sub> | Input leakage current                        | T <sub>A</sub> = 125°C                       |                       | 40    |                       | nA                |
| · ·               | M PERFORMANCE                                | -  |                       |       |                       |                   |
|                   | Resolution                                   |  |                       | 10    |                       | Bits              |
|                   | No missing codes                             |  | 10                    |       |                       | Bits              |
| INL               | Integral nonlinearity                        |  | -0.75                 | ±0.35 | 0.75                  | LSB <sup>(3</sup> |
| DNL               | Differential nonlinearity                    |  | -0.5                  | ±0.35 | 0.5                   | LSB               |
| Eo                | Offset error <sup>(4)(5)(6)</sup>            |  | -1.5                  | ±0.5  | 1.5                   | LSB               |
| E <sub>G</sub>    | Gain error <sup>(5)</sup>                    |  | -1                    | ±0.5  | 1                     | LSB               |
| SAMPL             | ING DYNAMICS                                 |  | L.                    |       |                       |                   |
|                   | Conversion time                              | 25-MHz SCLK                                  | 530                   | 560   |                       | ns                |
|                   | Acquisition time                             |  | 260                   |       |                       | ns                |
|                   | Maximum throughput rate                      | 25-MHz SCLK                                  |                       |       | 1.25                  | MHz               |
|                   | Aperture delay                               |  |                       | 5     |                       | ns                |
|                   | Step Response                                |  |                       | 160   |                       | ns                |
|                   | Overvoltage recovery                         |  |                       | 160   |                       | ns                |
| DYNAM             |  |  |                       |       |                       |                   |
| THD               | Total harmonic distortion <sup>(7)</sup>     | 100 kHz                                      |                       | -84   | -72                   | dB                |
| SINAD             | Signal-to-noise and distortion               | 100 kHz                                      | 60.5                  | 61    |                       | dB                |
| SFDR              | Spurious free dynamic range                  | 100 kHz                                      | 73                    | 81    |                       | dB                |
|                   | Full power bandwidth                         | At –3 dB                                     |                       | 15    |                       | MHz               |
| DIGITA            | L INPUT/OUTPUT                               |  |                       |       |                       |                   |
| V <sub>IH</sub>   | High-level input voltage                     | VDD = 2.35 V to 5.25 V                       | V <sub>DD</sub> – 0.4 |       | 5.25                  | V                 |
|                   |  | $V_{DD} = 5 V$                               | 00 -                  |       | 0.8                   |                   |
| V <sub>IL</sub>   | Low-level input voltage                      | V <sub>DD</sub> = 3 V                        |                       |       | 0.4                   | V                 |
| V <sub>OH</sub>   | High-level output voltage                    | At I <sub>source</sub> = 200 µA              | V <sub>DD</sub> – 0.2 |       | -                     |                   |
| V <sub>OL</sub>   | Low-level output voltage                     | At I <sub>sink</sub> = 200 µA                |                       |       | 0.4                   | V                 |
|                   | SUPPLY REQUIREMENTS                          |  |                       |       |                       |                   |
| +V <sub>DD</sub>  | Supply voltage                               |  | 2.35                  | 3.3   | 5.25                  | V                 |
|                   |  | At V <sub>DD</sub> = 2.35 V to 5.25 V,       | 2.00                  | 0.0   |                       | -                 |
|                   | Supply current (normal mode)                 | 1.25-MHz throughput                          |                       |       | 2                     | mA                |
|                   |  | At $V_{DD}$ = 2.35 V to 5.25 V, static state |                       |       | 1.5                   |                   |
|                   |  | SCLK off                                     |                       |       | 1                     |                   |
|                   | Power-down state supply current              | SCLK on (25 MHz)                             |                       |       | 200                   | μA                |
|                   | Power dissipation                            | V <sub>DD</sub> = 5 V                        |                       | 8     | 10                    | - 1A/             |
|                   | at 1.25-MHz throughput                       | V <sub>DD</sub> = 3 V                        |                       | 3.8   | 6                     | mW                |
|                   |  | $V_{DD} = 5 V$                               |                       | 5.5   | 7.5                   |                   |
|                   | Power dissipation in static state            | V <sub>DD</sub> = 3 V                        |                       | 3     | 4.5                   | mW                |
|                   | Power-down time                              |  |                       |       | 0.1                   | μs                |

Ideal input span; does not include gain or offset error.
Refer Figure 31 for details on sampling circuit
LSB means least significant bit

Measured relative to an ideal full-scale input (4)

Offset error and gain error ensured by characterization. First transition of 000H to 001H at  $0.5 \times (V_{ref}/2^{10})$ (5)

(6)

Calculated on the first nine harmonics of the input frequency (7)

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# **Electrical Characteristics – ADS7887 (continued)**

+V<sub>DD</sub> = 2.35 V to 5.25 V,  $T_A = -40^{\circ}$ C to 125°C, and  $f_{sample} = 1.25$  MHz (unless otherwise noted)

| PARAMETER                          | TEST CONDITIONS | MIN | TYP | MAX | UNIT |
|------------------------------------|-----------------|-----|-----|-----|------|
| Power-up time                      |                 |     |     | 0.8 | μs   |
| Invalid conversions after power up |                 |     |     | 1   |      |

### 8.6 Electrical Characteristics – ADS7888

 $+V_{DD} = 2.35$  V to 5.25 V,  $T_A = -40^{\circ}$ C to 125°C, and  $f_{sample} = 1.25$  MHz (unless otherwise noted)

|                   | PARAMETER                                    | TEST CONDITIONS                                     | MIN                   | TYP   | MAX                   | UNIT               |
|-------------------|--|---|-----------------------|-------|-----------------------|--------------------|
| ANALC             | OG INPUT                                     |   |                       |       |                       |                    |
|                   | Full-scale input voltage span <sup>(1)</sup> |   | 0                     |       | $V_{DD}$              | V                  |
|                   | Absolute input voltage range                 | +IN   | -0.2                  | ١     | / <sub>DD</sub> + 0.2 | V                  |
| Ci                | Input capacitance <sup>(2)</sup>             |   |                       | 21    |                       | pF                 |
| l <sub>likg</sub> | Input leakage current                        | T <sub>A</sub> = 125°C                              |                       | 40    |                       | nA                 |
| SYSTE             | M PERFORMANCE                                |   |                       |       |                       |                    |
|                   | Resolution                                   |   |                       | 8     |                       | Bits               |
|                   | No missing codes                             |   | 8                     |       |                       | Bits               |
| INL               | Integral nonlinearity                        |   | -0.3                  | ±0.15 | 0.3                   | LSB <sup>(3)</sup> |
| DNL               | Differential nonlinearity                    |   | -0.3                  | ±0.1  | 0.3                   | LSB                |
| Eo                | Offset error <sup>(4)</sup> (5) (6)          |   | -0.5                  | ±0.15 | 0.5                   | LSB                |
| E <sub>G</sub>    | Gain error <sup>(5)</sup>                    |   | -0.5                  | ±0.15 | 0.5                   | LSB                |
| SAMPL             | ING DYNAMICS                                 |   | -!                    |       |                       |                    |
|                   | Conversion time                              | 25-MHz SCLK   | 450                   | 480   |                       | ns                 |
|                   | Acquisition time                             | 1.5 MSPS mode, see Figure 34                        | 206                   |       |                       | ns                 |
|                   | Maximum throughput rate                      | 25-MHz SCLK   |                       |       | 1.25                  | MHz                |
|                   | Aperture delay                               |   |                       | 5     |                       | ns                 |
|                   | Step Response                                |   |                       | 160   |                       | ns                 |
|                   | Overvoltage recovery                         |   |                       | 160   |                       | ns                 |
| DYNAM             | IC CHARACTERISTICS                           |   |                       |       |                       |                    |
| THD               | Total harmonic distortion <sup>(7)</sup>     | 100 kHz   |                       | -67.5 | -65                   | dB                 |
| SINAD             | Signal-to-noise and distortion               | 100 kHz   | 49                    | 49.5  |                       | dB                 |
| SFDR              | Spurious free dynamic range                  | 100 kHz   | 65                    | 77    |                       | dB                 |
|                   | Full power bandwidth                         | At –3 dB  |                       | 15    |                       | MHz                |
| DIGITA            | L INPUT/OUTPUT                               |   |                       |       |                       |                    |
| V <sub>IH</sub>   | High-level input voltage                     | V <sub>DD</sub> = 2.35 V to 5.25 V                  | V <sub>DD</sub> - 0.4 |       | 5.25                  | V                  |
|                   | Law law literation to a trans                | $V_{DD} = 5 V$                                      |                       |       | 0.8                   |                    |
| V <sub>IL</sub>   | Low-level input voltage                      | $V_{DD} = 3 V$                                      |                       |       | 0.4                   | V                  |
| V <sub>OH</sub>   | High-level output voltage                    | At I <sub>source</sub> = 200 μA                     | V <sub>DD</sub> - 0.2 |       |                       |                    |
| V <sub>OL</sub>   | Low-level output voltage                     | At I <sub>sink</sub> = 200 μA                       |                       |       | 0.4                   | V                  |
|                   | R SUPPLY REQUIREMENTS                        |   | ·                     |       | L                     |                    |
| +V <sub>DD</sub>  | Supply voltage                               |   | 2.35                  | 3.3   | 5.25                  | V                  |
|                   | Supply current (normal mode)                 | At $V_{DD}$ = 2.35 V to 5.25 V, 1.25-MHz throughput |                       |       | 2                     | mA                 |
|                   |  | At $V_{DD}$ = 2.35 V to 5.25 V, static state        |                       |       | 1.5                   |                    |

(1) Ideal input span; does not include gain or offset error.

(2) Refer Figure 31 for details on sampling circuit

(3) LSB means least significant bit

(4) Measured relative to an ideal full-scale input

(5) Offset error and gain error ensured by characterization.

(6) First transition of 000H to 001H at (V<sub>ref</sub>/2<sup>8</sup>)

(7) Calculated on the first nine harmonics of the input frequency

8 Submit Documentation Feedback

UNIT

μΑ

mW

mW

μs

μs

1

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### **Electrical Characteristics – ADS7888 (continued)**

| $+V_{DD} = 2.35$ V to 5.25 V, $T_A = -40^{\circ}$ C to 125° | °C, and f <sub>sample</sub> = 1.25 MHz (unless otherv | wise noted) |     |     |   |
|---|---|-------------|-----|-----|---|
| PARAMETER   | TEST CONDITIONS                                       | MIN         | TYP | MAX | l |
| Power-down state supply current                             | SCLK off  |             |     | 1   | I |
| Power-down state supply current                             | SCLK on (25 MHz)                                      |             |     | 200 |   |
| Power dissipation at 1.25 MHz                               | $V_{DD} = 5 V$  |             | 8   | 10  | I |
| throughput  | V <sub>DD</sub> = 3 V                                 |             | 3.8 | 6   | I |
| Power dissipation in static state                           | $V_{DD} = 5 V$  |             | 5.5 | 7.5 |   |
|   | $V_{DD} = 3 V$  |             | 3   | 4.5 |   |
| Power-down time   |   |             |     | 0.1 |   |
| Power-up time   |   |             |     | 0.8 | I |

0.05.1/4  $\mathbf{v}$ .....

# 8.7 Timing Requirements

Invalid conversions after power up

All specifications typical at  $T_A = -40^{\circ}$ C to 125°C and  $V_{DD} = 2.35$  V to 5.25 V (unless otherwise noted; see Figure 32)

| PARAMETER                  |                                       | TEST CONDITIONS <sup>(1)</sup>  | MIN                   | TYP                     | MAX | UNIT                   |     |  |
|----------------------------|---------------------------------------|---|-----------------------|-------------------------|-----|------------------------|-----|--|
|                            |                                       | 4007007   | $V_{DD} = 3 V$        |                         |     | 14 × t <sub>SCLK</sub> |     |  |
|                            | 0                                     | ADS7887   | $V_{DD} = 5 V$        |                         |     | 14 × t <sub>SCLK</sub> |     |  |
| t <sub>conv</sub>          | Conversion time                       | 4007000   | $V_{DD} = 3 V$        |                         |     | 12 × t <sub>SCLK</sub> | ns  |  |
|                            |                                       | ADS7888   | $V_{DD} = 5V$         |                         |     | 12 × t <sub>SCLK</sub> |     |  |
|                            | Ordentiere                            | Minimum time required from bus 3-state  | $V_{DD} = 3 V$        | 40                      |     |                        |     |  |
| tq                         | Quiet time                            | to start of next conversion   | $V_{DD} = 5 V$        | 40                      |     |                        | ns  |  |
|                            | Delay fina                            |   | $V_{DD} = 3 V$        |                         | 15  | 25                     |     |  |
| t <sub>d1</sub>            | Delay time                            | CS low to first data (0) out  | V <sub>DD</sub> = 5 V |                         | 13  | 25                     | ns  |  |
|                            | Catura time a                         |   | $V_{DD} = 3 V$        | 10                      |     |                        |     |  |
| t <sub>su1</sub>           | Setup time                            | CS low to SCLK low  | $V_{DD} = 5 V$        | 10                      |     |                        | ns  |  |
|                            |                                       |   | $V_{DD} = 3 V$        |                         | 15  | 25                     |     |  |
| t <sub>d2</sub>            | Delay time                            | SCLK falling to SDO   | $V_{DD} = 5 V$        |                         | 13  | 25                     | ns  |  |
|                            | t Hold time                           | SCLK falling to data valid (with 50-pF  | V <sub>DD</sub> < 3 V | 7                       |     |                        |     |  |
| t <sub>h1</sub>            | Hold time                             | load)   | V <sub>DD</sub> > 5 V | 5.5                     |     |                        | ns  |  |
|                            |                                       |   | $V_{DD} = 3 V$        |                         | 10  | 25                     | 00  |  |
| t <sub>d3</sub> Delay time | 16th SCLK falling edge to SDO 3-state | $V_{DD} = 5 V$  |                       | 8                       | 20  | ns                     |     |  |
|                            |                                       | $V_{DD} = 3 V$  | 25                    | 40                      |     |                        |     |  |
| t <sub>w1</sub>            | Pulse duration                        | CS  | V <sub>DD</sub> = 5 V | 25                      | 40  |                        | ns  |  |
|                            | Delay fina                            |   | $V_{DD} = 3 V$        |                         | 17  | 30                     |     |  |
| t <sub>d4</sub>            | Delay time                            | CS high to SDO 3-state, see Figure 34   | $V_{DD} = 5 V$        |                         | 15  | 25                     | ns  |  |
|                            | Data dan tan                          |   | $V_{DD} = 3 V$        | 0.4 × t <sub>SCLK</sub> |     |                        |     |  |
| t <sub>wH</sub>            | Pulse duration                        | SCLK high   | V <sub>DD</sub> = 5 V | 0.4 × t <sub>SCLK</sub> |     |                        | ns  |  |
|                            | Dulas duration                        |   | $V_{DD} = 3 V$        | 0.4 × t <sub>SCLK</sub> |     |                        |     |  |
| t <sub>wL</sub>            | Pulse duration                        | SCLK low  | $V_{DD} = 5 V$        | 0.4 × t <sub>SCLK</sub> |     |                        | ns  |  |
|                            | Frequency                             | V <sub>DD</sub> = 3   | $V_{DD} = 3 V$        |                         |     | 25                     |     |  |
|                            | Frequency                             | SCLK  | $V_{DD} = 5 V$        |                         |     | 25                     | MHz |  |
|                            |                                       | Second falling edge of clock and $\overline{CS}$ to   | $V_{DD} = 3 V$        | -2                      |     | 5                      |     |  |
| t <sub>d5</sub> Delay time |                                       | enter in power down (use min spec not to<br>accidently enter in power down, see<br>Figure 35) | V <sub>DD</sub> = 5 V | -2                      |     | 5                      | ns  |  |
|                            |                                       | CS and 10th falling edge of clock to enter  |                       | 2                       |     | -5                     |     |  |
| t <sub>d6</sub> Delay time |                                       | in power down (use max spec not to<br>accidently enter in power down, see<br>Figure 35)       | V <sub>DD</sub> = 5 V | 2                       |     | -5                     | ns  |  |

(1) 3-V Specifications apply from 2.35 V to 3.6 V, and 5-V specifications apply from 4.75 V to 5.25 V.

ADS7887, ADS7888

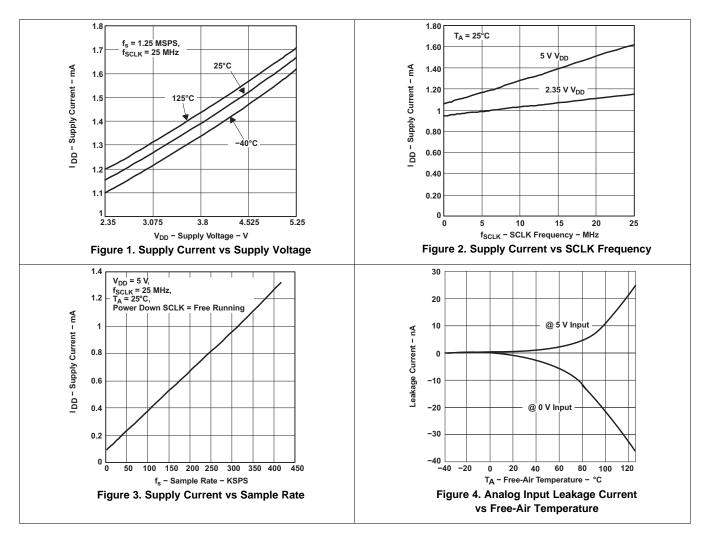
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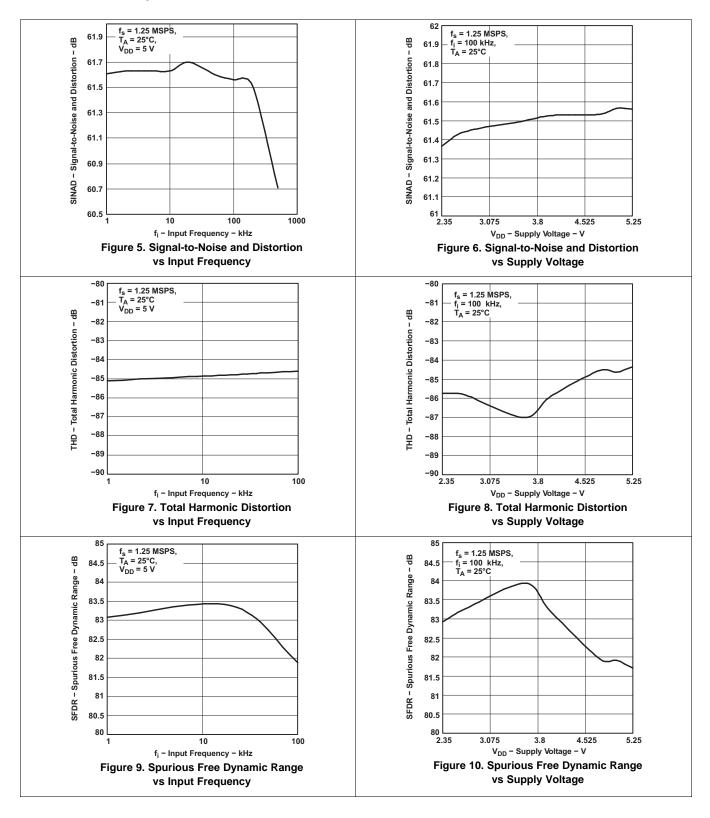
#### 8.8 Typical Characteristics

#### 8.8.1 ADS7887 and ADS7888





#### 8.8.2 ADS7887 Only



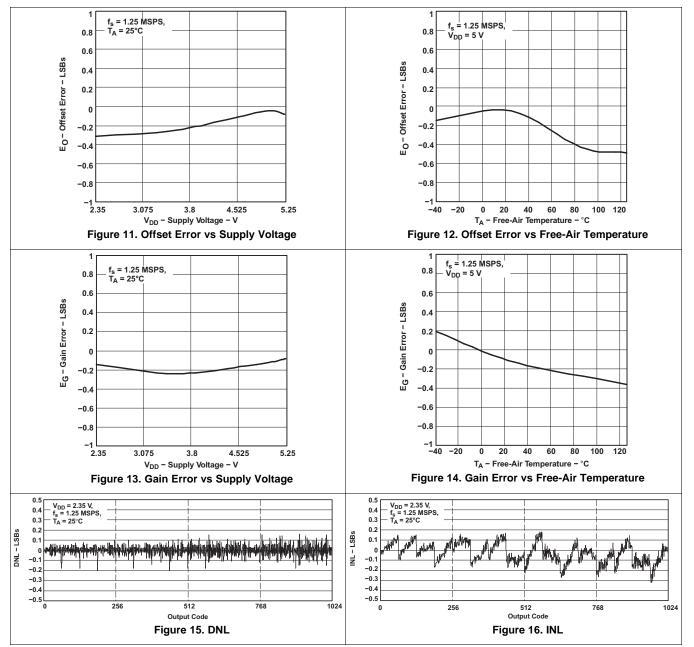
#### ADS7887, ADS7888

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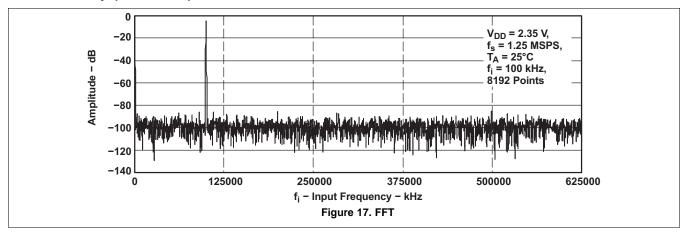
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### ADS7887 Only (continued)

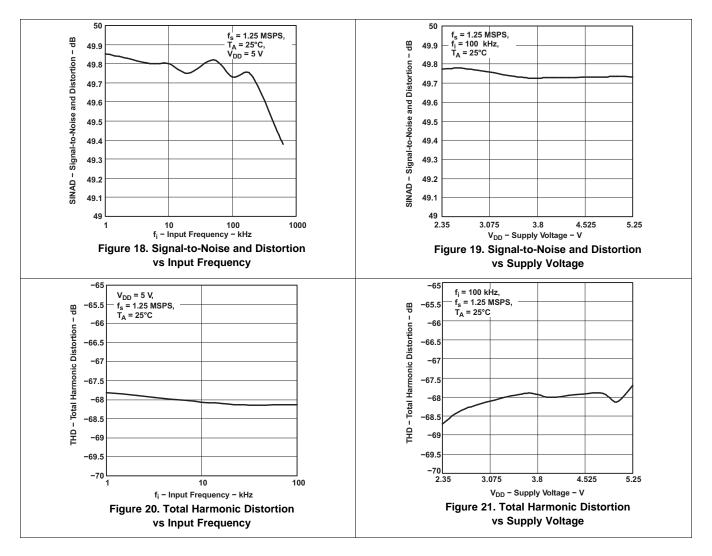




#### ADS7887 Only (continued)



#### 8.8.3 ADS7888 Only



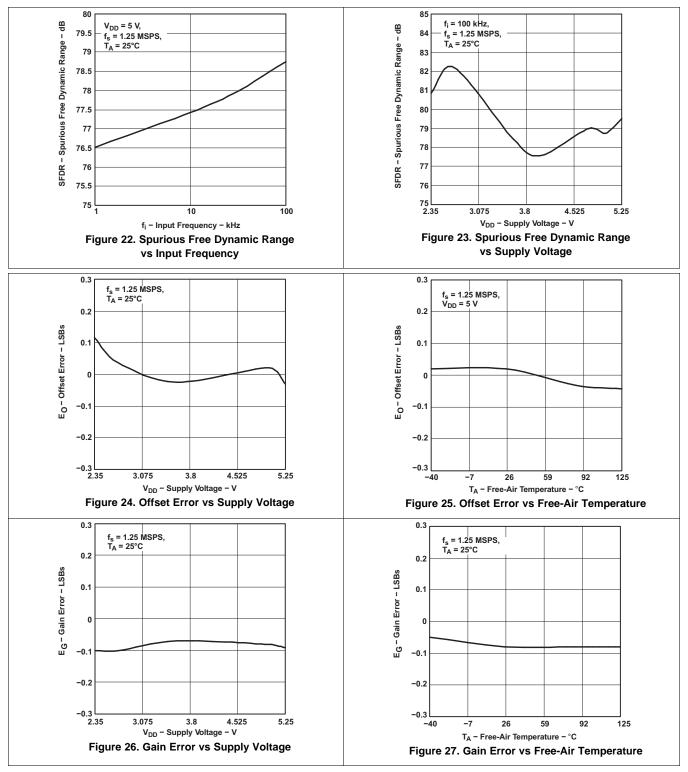
#### ADS7887, ADS7888

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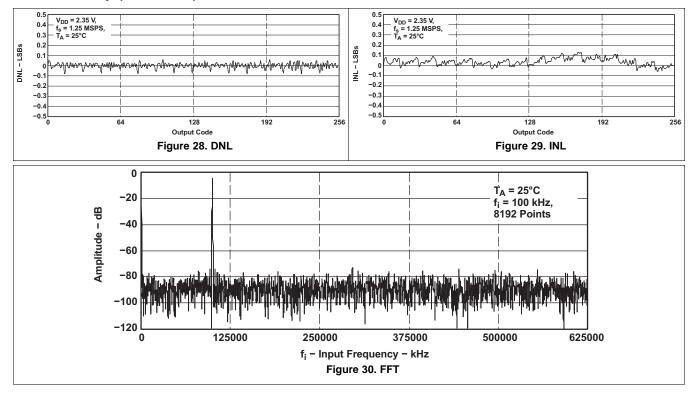
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#### ADS7888 Only (continued)





### ADS7888 Only (continued)





# 9 Detailed Description

#### 9.1 Overview

The ADS788x devices are ADC converters. The serial interface in each device is controlled by the  $\overline{CS}$  and SCLK signals for easy interface with microprocessors and DSPs. The input signal is sampled with the falling edge of CS, and SCLK is used for conversion and serial data output. They both operate in a wide supply range from 2.35 V to 5.25 V and low power consumption makes them suitable for battery-powered applications.

#### 9.1.1 Driving the VIN and V<sub>DD</sub> Pins of the ADS7887 and ADS7888

The VIN input to the ADS7887 and ADS7888 must be driven with a low impedance source. In most cases additional buffers are not required. In cases where the source impedance exceeds 200  $\Omega$ , using a buffer would help achieve the rated performance of the converter. The THS4031 is a good choice for the driver amplifier buffer.

The reference voltage for the ADS7887 and ADS7888 A/D converters are derived from the supply voltage internally. The devices offer limited low-pass filtering functionality on-chip. The supply to these converters must be driven with a low impedance source and must be decoupled to the ground. A 1- $\mu$ F storage capacitor and a 10-nF decoupling capacitor must be placed close to the device. Wide, low impedance traces must be used to connect the capacitor to the pins of the device. The ADS7887 and ADS7888 draw very little current from the supply lines. The supply line can be driven by either:

- Directly from the system supply.
- A reference output from a low drift and low dropout reference voltage generator like REF3030 or REF3130. The ADS7887 and ADS7888 can operate off a wide range of supply voltages. The actual choice of the reference voltage generator would depend upon the system. Figure 41 shows one possible application circuit.
- A low-pass filtered version of the system supply followed by a buffer like the zero-drift OPA735 can also be used in cases where the system power supply is noisy. Take care to ensure that the voltage at the V<sub>DD</sub> input does not exceed 7 V (especially during power up) to avoid damage to the converter. This can be done easily using single-supply CMOS amplifiers like the OPA735. Figure 42 shows one possible application circuit.

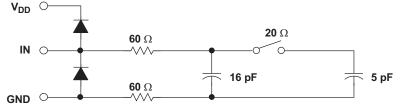
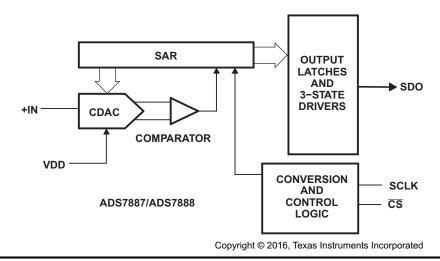


Figure 31. Typical Equivalent Sampling Circuit

# 9.2 Functional Block Diagram





#### 9.3 Feature Description

# 9.3.1 ADS7887 Operation

The cycle begins with the falling edge of  $\overline{CS}$ . This point is indicated as a in Figure 32. With the falling edge of  $\overline{CS}$ , the input signal is sampled and the conversion process is initiated. The device outputs data while the conversion is in progress. The data word contains 4 leading zeros, followed by 10-bit data in MSB first format and padded by 2 lagging zeros.

The falling edge of  $\overline{CS}$  clocks out the first zero, and a zero is clocked out on every falling edge of the clock until the third edge. Data is in MSB first format with the MSB being clocked out on the 4th falling edge. Data is padded with two lagging zeros as shown in Figure 32. On the 16th falling edge of SCLK, SDO goes to the 3-state condition. The conversion ends on the 14th falling edge of SCLK. The device enters the acquisition phase on the first rising edge of SCLK after the 13th falling edge. This point is indicated by *b* in Figure 32.

 $\overline{CS}$  can be asserted (pulled high) after 16 clocks have elapsed. It is necessary not to start the next conversion by pulling  $\overline{CS}$  low until the end of the quiet time (t<sub>q</sub>) after SDO goes to 3-state. To continue normal operation, it is necessary that  $\overline{CS}$  is not pulled high until point *b*. Without this, the device does not enter the acquisition phase and no valid data is available in the next cycle (refer to *Power-Down Mode* for more details).  $\overline{CS}$  going high any time after the conversion start aborts the ongoing conversion and SDO goes to 3-state.

The high level of the digital input to the device is not limited to device  $V_{DD}$ . This means the digital input can go as high as 5.25 V when the device supply is 2.35 V. This feature is useful when digital signals are coming from another circuit with different supply levels. Also, this relaxes the restriction on power-up sequencing. However, the digital output levels (V<sub>OH</sub> and V<sub>OL</sub>) are governed by V<sub>DD</sub> as listed in *Specifications*.

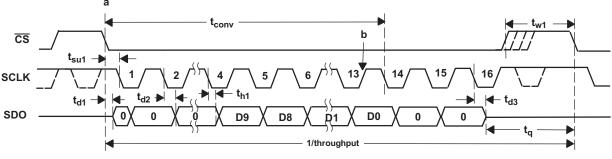


Figure 32. ADS7887 Interface Timing Diagram

# 9.3.2 ADS7888 Operation

The cycle begins with the falling edge of  $\overline{CS}$ . This point is indicated as *a* in Figure 33. With the falling edge of  $\overline{CS}$ , the input signal is sampled and the conversion process is initiated. The device outputs data while the conversion is in progress. The data word contains 4 leading zeros, followed by 8-bit data in MSB first format and padded by 4 lagging zeros.

The falling edge of  $\overline{CS}$  clocks out the first zero, and a zero is clocked out on every falling edge of the clock until the third edge. Data is in MSB first format with the MSB being clocked out on the 4th falling edge. Data is padded with four lagging zeros as shown in Figure 33. On the 16th falling edge of SCLK, SDO goes to the 3-state condition. The conversion ends on the 12th falling edge of SCLK. The device enters the acquisition phase on the first rising edge of SCLK after the 11th falling edge. This point is indicated by *b* in Figure 33.

 $\overline{CS}$  can <u>be</u> asserted (pulled high) after 16 clocks have elapsed. It is necessary not to start the next conversion by pulling  $\overline{CS}$  low <u>until</u> the end of the quiet time (t<sub>q</sub>) after SDO goes to 3-state. To continue normal operation, it is necessary that  $\overline{CS}$  is not pulled high until point *b*. Without this, the device does not enter the acquisition phase and no valid data is available in the next cycle (refer to *Power-Down Mode* for more details).  $\overline{CS}$  going high any time after the conversion start aborts the ongoing conversion and SDO goes to 3-state.

The high level of the digital input to the device is not limited to device  $V_{DD}$ . This means the digital input can go as high as 5.25 V when the device supply is 2.35 V. This feature is useful when digital signals are coming from another circuit with different supply levels. Also, this relaxes the restriction on power-up sequencing. However, the digital output levels (V<sub>OH</sub> and V<sub>OL</sub>) are governed by V<sub>DD</sub> as listed in *Specifications*.

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### Feature Description (continued)

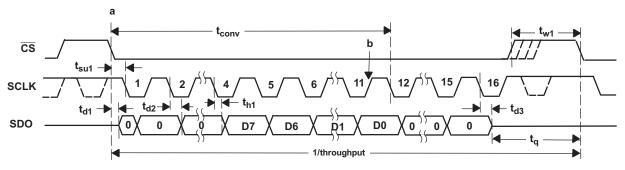


Figure 33. ADS7888 Interface Timing Diagram

As shown in Figure 34, the ADS7888 can achieve 1.5-MSPS throughput.  $\overline{CS}$  can be pulled high after the 12th falling edge (with a 25-MHz SCLK). SDO goes to 3-state after the LSB (as  $\overline{CS}$  is high).  $\overline{CS}$  can be pulled low at the end of the quiet time (t<sub>g</sub>) after SDO goes to 3-state.

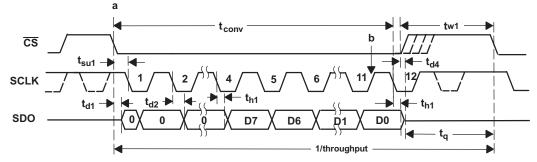


Figure 34. ADS7888 Interface Timing Diagram, Data Transfer With 12-Clock Frame

# 9.4 Device Functional Modes

### 9.4.1 Power-Down Mode

The device enters power-down mode if  $\overline{CS}$  goes high anytime after the 2nd SCLK falling edge to before the 10th SCLK falling edge. Ongoing conversion stops and SDO goes to 3-state under this power-down condition as shown in Figure 35.

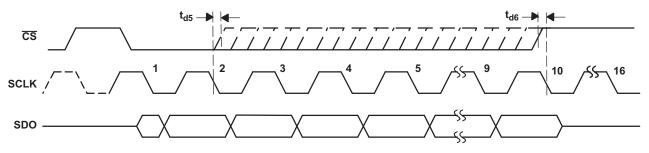


Figure 35. Entering Power-Down Mode

A dummy cycle with  $\overline{CS}$  low for more than 10 SCLK falling edges brings the device out of power-down mode. For the device to come to the fully powered-up condition it takes 0.8 µs.  $\overline{CS}$  can be pulled high any time after the 10th falling edge as shown in Figure 36. It is not necessary to continue until the 16th clock if the next conversion starts 0.8 µs after  $\overline{CS}$  going low of the dummy cycle and the quiet time (t<sub>a</sub>) condition is met.



# **Device Functional Modes (continued)**

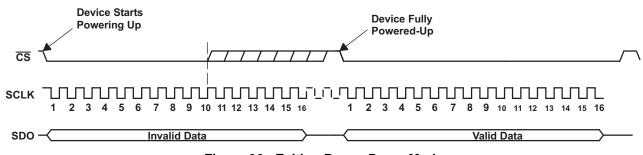


Figure 36. Exiting Power-Down Mode



### **10** Application and Implementation

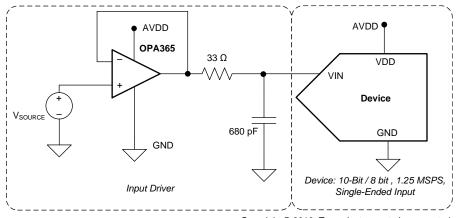
#### NOTE

Information in the following applications sections is not part of the TI component specification, and TI does not warrant its accuracy or completeness. TI's customers are responsible for determining suitability of components for their purposes. Customers should validate and test their design implementation to confirm system functionality.

#### **10.1** Application Information

The primary circuits required to maximize the performance of a high-precision, the successive approximation register (SAR) and analog-to-digital converter (ADC), are the input driver and the reference driver circuits. This section details some general principles for designing the input driver circuit, references the driver circuit, and provides some application circuits designed for the ADS7887 and ADS7888.

#### **10.2 Typical Application**



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Figure 37. Typical Data Acquisition (DAQ) Circuit: Single-Supply DAQ

#### 10.2.1 Design Requirements

The goal of this application is to design a single-supply digital acquisition (DAQ) circuit based on the ADS7887 with SNR greater than 61 dB and THD less than -84 dB for input frequencies of 2 kHz to 100 kHz at a throughput of 1.25 MSPS.

#### 10.2.2 Detailed Design Procedure

To achieve a SINAD of 61 dB, the operational amplifier must have high bandwidth to settle the input signal within the acquisition time of the ADC. The operational amplifier must have low noise to keep the total system noise below 20% of the input-referred noise of the ADC. For the application circuit shown in Figure 37, OPA365 is selected for its high bandwidth (50 MHz) and low noise (4.5 nV $\sqrt{Hz}$ ).

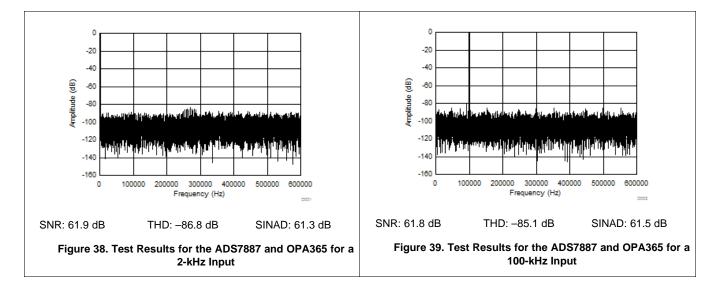
The reference voltage for the ADS7887 and ADS7888 A/D converters are derived from the supply voltage internally. The supply to these converters must be driven with a low impedance source and must be decoupled to the ground. To drive supply pin of ADS7887 ultra low noise fast transient response low dropout voltage regulator TPS73201 is selected. Alternatively one can drive supply pin with low impedance voltage reference similar to REF3030.

For a step-by-step design procedure for low power, small form factor digital acquisition (DAQ) circuit based on similar SAR ADCs refer to TI Precision Design, *Three 12-Bit Data Acquisition Reference Designs Optimized for Low Power and Ultra-Small Form Factor*.



### **Typical Application (continued)**

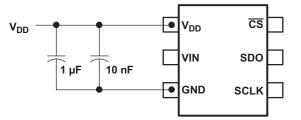
# 10.2.3 Application Curves





### 11 Power Supply Recommendations

The reference voltage for the ADS7887 and ADS7888 A/D converters are derived from the supply voltage internally. The supply to these converters must be driven with a low impedance source and must be decoupled to the ground Decouple the  $V_{DD}$  with 1-µF ceramic decoupling capacitors, as shown in Figure 40. Always set the  $V_{DD}$  supply to be greater than or equal to the maximum input signal to avoid saturation of codes.





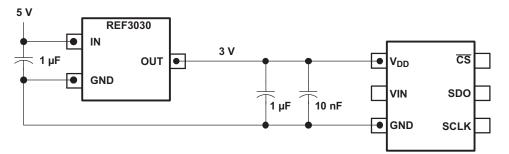


Figure 41. Using the REF3030 Reference

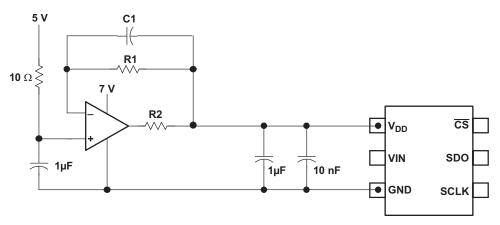


Figure 42. Buffering With the OPA735



# 12 Layout

### 12.1 Layout Guidelines

Figure 43 shows a board layout example for the ADS7887 and ADS7888. Some of the key considerations are:

- 1. Use a ground plane underneath the device and partition the PCB into analog and digital sections.
- 2. Avoid crossing digital lines with the analog signal path.
- The power sources to the device must be clean and well-bypassed. Use 1-µF ceramic bypass capacitors in close proximity to the supply pin (VDD).
- 4. Avoid placing vias between the VDD and bypass capacitors.
- 5. Connect ground pin to the ground plane using short, low-impedance path.
- 6. The fly-wheel RC filters are placed close to the device.

Among ceramic surface-mount capacitors, COG (NPO) ceramic capacitors provide the best capacitance precision. The type of dielectric used in COG (NPO) ceramic capacitors provides the most stable electrical properties over voltage, frequency, and temperature changes.

### 12.2 Layout Example

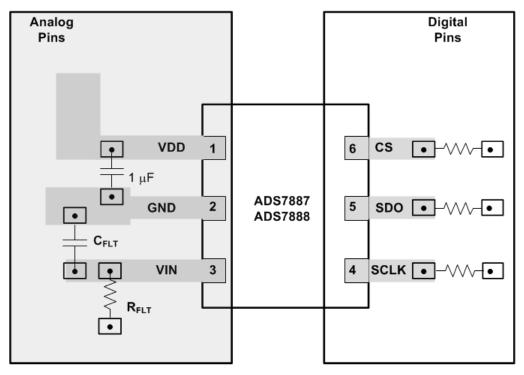


Figure 43. ADS7887 and ADS7888 Example Layout

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# **13** Device and Documentation Support

#### **13.1 Documentation Support**

#### 13.1.1 Related Documentation

For related documentation see the following:

- 50MHz, Low-Distortion, High CMRR, RRI/O, Single-Supply Operational Amplifier (SBOS365)
- Cap-Free NMOS 250-mA Low Dropout Regulator With Reverse Current Protection (SGLS346)
- Three 12-Bit Data Acquisition Reference Designs Optimized for Low Power and Ultra-Small Form Factor (TIDU390)

#### 13.2 Related Links

The table below lists quick access links. Categories include technical documents, support and community resources, tools and software, and quick access to sample or buy.

| Table 1. Related Links | Table | 1. | Related | Links |
|------------------------|-------|----|---------|-------|
|------------------------|-------|----|---------|-------|

| PARTS   | PRODUCT FOLDER | SAMPLE & BUY | TECHNICAL<br>DOCUMENTS | TOOLS &<br>SOFTWARE | SUPPORT &<br>COMMUNITY |
|---------|----------------|--------------|------------------------|---------------------|------------------------|
| ADS7887 | Click here     | Click here   | Click here             | Click here          | Click here             |
| ADS7888 | Click here     | Click here   | Click here             | Click here          | Click here             |

### 13.3 Receiving Notification of Documentation Updates

To receive notification of documentation updates, navigate to the device product folder on ti.com. In the upper right corner, click on *Alert me* to register and receive a weekly digest of any product information that has changed. For change details, review the revision history included in any revised document.

#### **13.4 Community Resources**

The following links connect to TI community resources. Linked contents are provided "AS IS" by the respective contributors. They do not constitute TI specifications and do not necessarily reflect TI's views; see TI's Terms of Use.

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**Design Support TI's Design Support** Quickly find helpful E2E forums along with design support tools and contact information for technical support.

#### 13.5 Trademarks

E2E is a trademark of Texas Instruments. All other trademarks are the property of their respective owners.

### 13.6 Electrostatic Discharge Caution



These devices have limited built-in ESD protection. The leads should be shorted together or the device placed in conductive foam during storage or handling to prevent electrostatic damage to the MOS gates.

# 13.7 Glossary

SLYZ022 — TI Glossary.

This glossary lists and explains terms, acronyms, and definitions.



# 14 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.



6-Feb-2020

# PACKAGING INFORMATION

| Orderable Device | Status | Package Type | Package<br>Drawing | Pins | Package<br>Qty |                            | Lead/Ball Finish | MSL Peak Temp       | Op Temp (°C) | Device Marking | Samples |
|------------------|--------|--------------|--------------------|------|----------------|----------------------------|------------------|---------------------|--------------|----------------|---------|
|                  | (1)    |              | Drawing            |      | QUY            | (2)                        | (6)              | (3)                 |              | (4/5)          |         |
| ADS7887SDBVR     | ACTIVE | SOT-23       | DBV                | 6    | 3000           | Green (RoHS<br>& no Sb/Br) | SN               | Level-2-260C-1 YEAR | -40 to 125   | BAWQ           | Samples |
| ADS7887SDBVT     | ACTIVE | SOT-23       | DBV                | 6    | 250            | Green (RoHS<br>& no Sb/Br) | SN               | Level-2-260C-1 YEAR | -40 to 125   | BAWQ           | Samples |
| ADS7887SDCKR     | ACTIVE | SC70         | DCK                | 6    | 3000           | Pb-Free (RoHS<br>Exempt)   | SN               | Level-2-260C-1 YEAR | -40 to 125   | BNI            | Samples |
| ADS7887SDCKT     | ACTIVE | SC70         | DCK                | 6    | 250            | Pb-Free (RoHS<br>Exempt)   | SN               | Level-2-260C-1 YEAR | -40 to 125   | BNI            | Samples |
| ADS7888SDBVR     | ACTIVE | SOT-23       | DBV                | 6    | 3000           | Green (RoHS<br>& no Sb/Br) | SN               | Level-2-260C-1 YEAR | -40 to 125   | BAZQ           | Samples |
| ADS7888SDBVT     | ACTIVE | SOT-23       | DBV                | 6    | 250            | Green (RoHS<br>& no Sb/Br) | SN               | Level-2-260C-1 YEAR | -40 to 125   | BAZQ           | Samples |
| ADS7888SDCKR     | ACTIVE | SC70         | DCK                | 6    | 3000           | Pb-Free (RoHS<br>Exempt)   | SN               | Level-2-260C-1 YEAR | -40 to 125   | BNH            | Samples |
| ADS7888SDCKT     | ACTIVE | SC70         | DCK                | 6    | 250            | Pb-Free (RoHS<br>Exempt)   | SN               | Level-2-260C-1 YEAR | -40 to 125   | BNH            | Samples |

<sup>(1)</sup> The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

**PREVIEW:** Device has been announced but is not in production. Samples may or may not be available.

**OBSOLETE:** TI has discontinued the production of the device.

<sup>(2)</sup> RoHS: TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".

**RoHS Exempt:** TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.

Green: TI defines "Green" to mean the content of Chlorine (CI) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of <=1000ppm threshold. Antimony trioxide based flame retardants must also meet the <=1000ppm threshold requirement.

<sup>(3)</sup> MSL, Peak Temp. - The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

<sup>(4)</sup> There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.



# PACKAGE OPTION ADDENDUM

6-Feb-2020

<sup>(5)</sup> Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.

<sup>(6)</sup> Lead/Ball Finish - Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead/Ball Finish values may wrap to two lines if the finish value exceeds the maximum column width.

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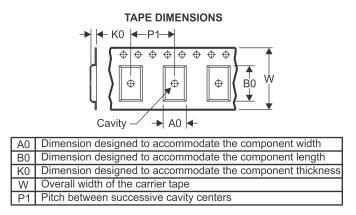
# PACKAGE MATERIALS INFORMATION

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# TAPE AND REEL INFORMATION





# QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



| *All dimensions are nominal |                 |                    |   |      |                          |                          |            |            |            |            |           |                  |
|-----------------------------|-----------------|--------------------|---|------|--------------------------|--------------------------|------------|------------|------------|------------|-----------|------------------|
| Device                      | Package<br>Type | Package<br>Drawing |   | SPQ  | Reel<br>Diameter<br>(mm) | Reel<br>Width<br>W1 (mm) | A0<br>(mm) | B0<br>(mm) | K0<br>(mm) | P1<br>(mm) | W<br>(mm) | Pin1<br>Quadrant |
| ADS7887SDBVR                | SOT-23          | DBV                | 6 | 3000 | 180.0                    | 8.4                      | 3.2        | 3.2        | 1.4        | 4.0        | 8.0       | Q3               |
| ADS7887SDCKR                | SC70            | DCK                | 6 | 3000 | 177.8                    | 9.7                      | 2.3        | 2.52       | 1.2        | 4.0        | 8.0       | Q3               |
| ADS7887SDCKT                | SC70            | DCK                | 6 | 250  | 177.8                    | 9.7                      | 2.3        | 2.52       | 1.2        | 4.0        | 8.0       | Q3               |
| ADS7888SDBVR                | SOT-23          | DBV                | 6 | 3000 | 180.0                    | 8.4                      | 3.2        | 3.2        | 1.4        | 4.0        | 8.0       | Q3               |
| ADS7888SDBVT                | SOT-23          | DBV                | 6 | 250  | 180.0                    | 8.4                      | 3.2        | 3.2        | 1.4        | 4.0        | 8.0       | Q3               |
| ADS7888SDCKR                | SC70            | DCK                | 6 | 3000 | 177.8                    | 9.7                      | 2.3        | 2.52       | 1.2        | 4.0        | 8.0       | Q3               |
| ADS7888SDCKT                | SC70            | DCK                | 6 | 250  | 177.8                    | 9.7                      | 2.3        | 2.52       | 1.2        | 4.0        | 8.0       | Q3               |

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# PACKAGE MATERIALS INFORMATION

8-Apr-2020



\*All dimensions are nominal

| Device       | Package Type | Package Drawing | Pins | SPQ  | Length (mm) | Width (mm) | Height (mm) |
|--------------|--------------|-----------------|------|------|-------------|------------|-------------|
| ADS7887SDBVR | SOT-23       | DBV             | 6    | 3000 | 195.0       | 200.0      | 45.0        |
| ADS7887SDCKR | SC70         | DCK             | 6    | 3000 | 184.0       | 184.0      | 50.0        |
| ADS7887SDCKT | SC70         | DCK             | 6    | 250  | 184.0       | 184.0      | 50.0        |
| ADS7888SDBVR | SOT-23       | DBV             | 6    | 3000 | 195.0       | 200.0      | 45.0        |
| ADS7888SDBVT | SOT-23       | DBV             | 6    | 250  | 195.0       | 200.0      | 45.0        |
| ADS7888SDCKR | SC70         | DCK             | 6    | 3000 | 184.0       | 184.0      | 50.0        |
| ADS7888SDCKT | SC70         | DCK             | 6    | 250  | 184.0       | 184.0      | 50.0        |

# **DBV0006A**



# **PACKAGE OUTLINE**

SOT-23 - 1.45 mm max height

SMALL OUTLINE TRANSISTOR



NOTES:

- 1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.2. This drawing is subject to change without notice.3. Body dimensions do not include mold flash or protrusion. Mold flash and protrusion shall not exceed 0.15 per side.

- 4. Leads 1,2,3 may be wider than leads 4,5,6 for package orientation. 5. Refernce JEDEC MO-178.



# **DBV0006A**

# **EXAMPLE BOARD LAYOUT**

# SOT-23 - 1.45 mm max height

SMALL OUTLINE TRANSISTOR



NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.

7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.



# **DBV0006A**

# **EXAMPLE STENCIL DESIGN**

# SOT-23 - 1.45 mm max height

SMALL OUTLINE TRANSISTOR



NOTES: (continued)

8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.

9. Board assembly site may have different recommendations for stencil design.



DCK (R-PDSO-G6)

PLASTIC SMALL-OUTLINE PACKAGE



- NOTES: A. All linear dimensions are in millimeters.
  - B. This drawing is subject to change without notice.
  - C. Body dimensions do not include mold flash or protrusion. Mold flash and protrusion shall not exceed 0.15 per side.
  - D. Falls within JEDEC MO-203 variation AB.



# LAND PATTERN DATA



NOTES:

- A. All linear dimensions are in millimeters.B. This drawing is subject to change without notice.
- C. Customers should place a note on the circuit board fabrication drawing not to alter the center solder mask defined pad.
- D. Publication IPC-7351 is recommended for alternate designs.
- E. Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Example stencil design based on a 50% volumetric metal load solder paste. Refer to IPC-7525 for other stencil recommendations.



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